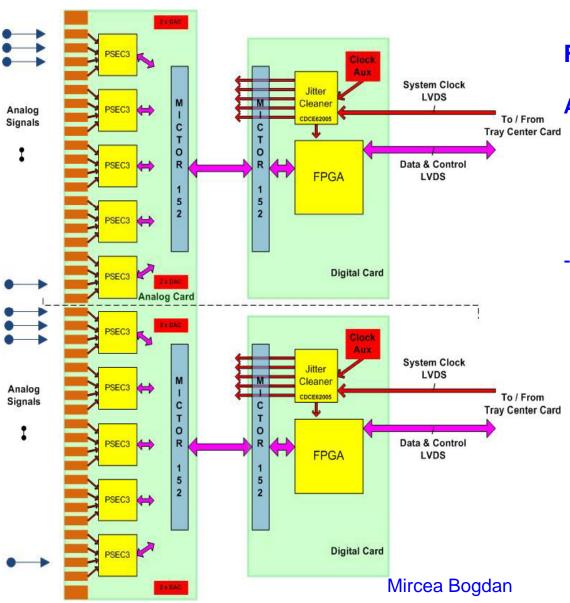
## PSEC Beam Test Readout System

The University of Chicago

LAPPD Electronics and Integration Godparent Review May 20, 2011

### PSEC DAQ - Front End



#### **Front End Electronics:**

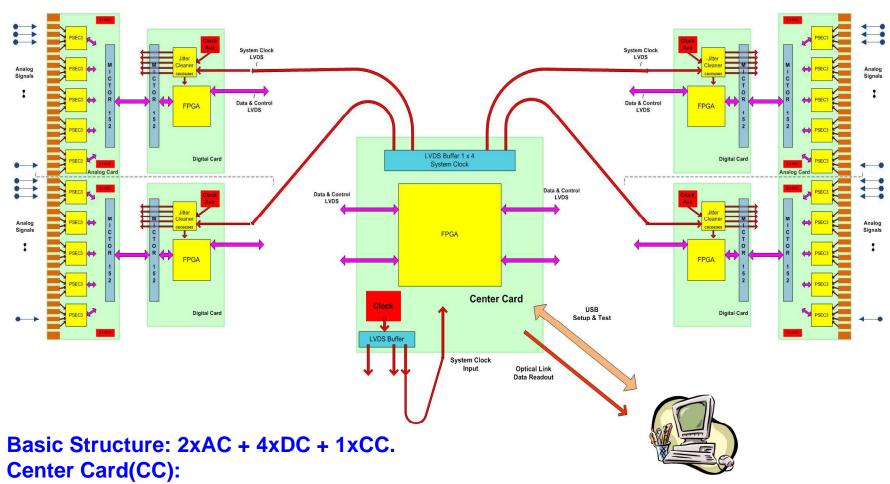
### **Analog Card**

- -Placed at Edge of Tile
- -Receives 40 analog signals
- -PSEC chips and DACs only
- -Minimal width

### -Digital Card

- -Services 1/2 Analog Card
- -System Clock Clean/Fanout
- -Interface between ASICs and Center Card

### PSEC DAQ - Basic Readout Structure

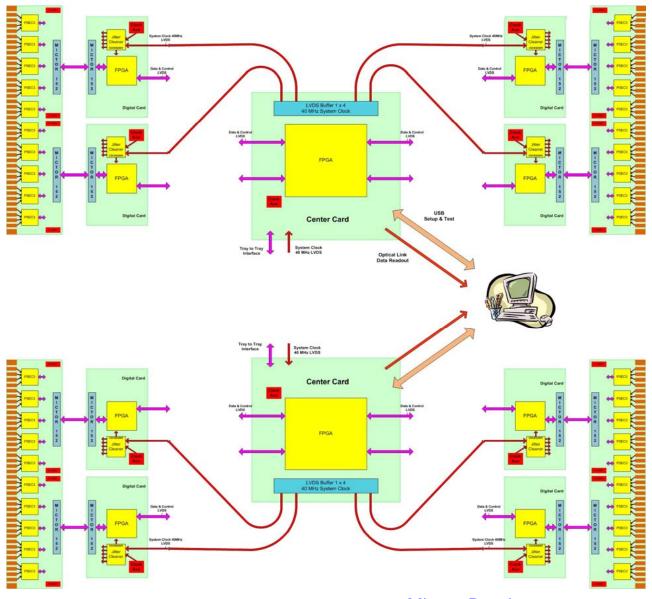


- -Can service 4 Digital Cards i.e. 2 Analog Cards placed at each end of the Tile;
- -Runs on external system clock;
- -Can generate system clock for other Center Cards and for itself.

Many such Basic Readout Structures can work in one system, on the same clock.

Mircea Bogdan

## **Beam Test Configuration**

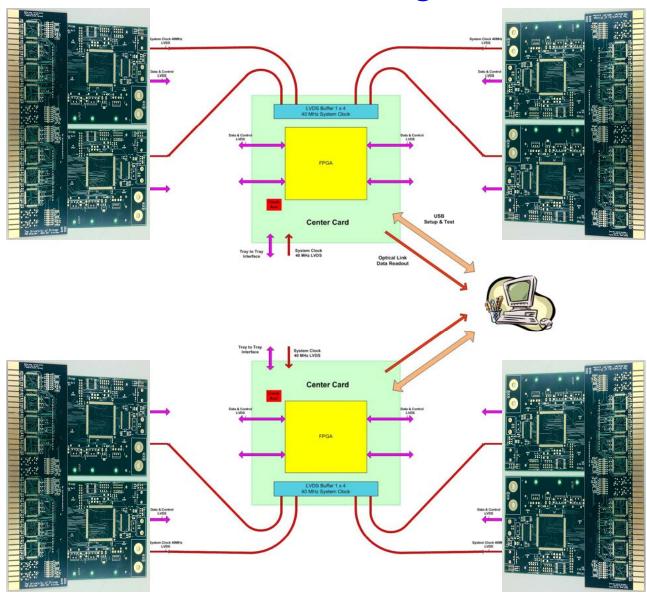


### **Custom Electronics:**

- -Analog Card -Rev.A Design exists
- -Digital Card -Rev.A Design exists
- -Center Card
  -New Design required

Mircea Bogdan

# **Beam Test Configuration**



### **Existing modules:**

-Analog Card: Rev.A-PSEC3

-Digital Card: Rev.A-1 ASIC

#### **New modules:**

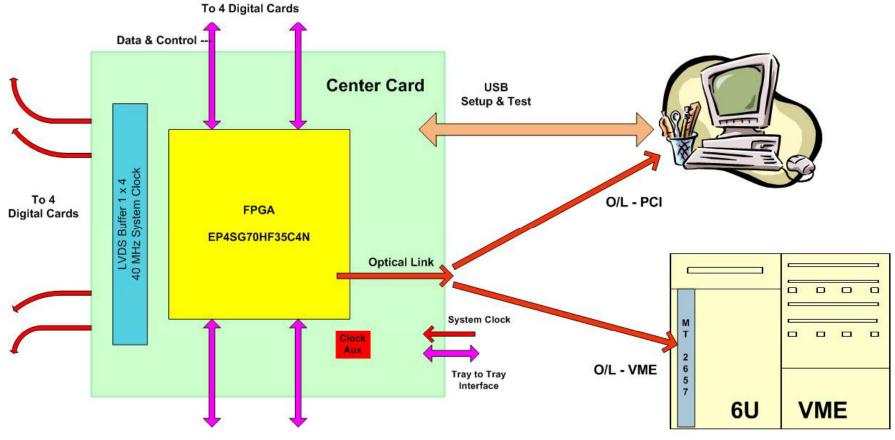
-Analog Card: Rev.B-PSEC3A

-Digital Card: Rev.B-5 ASICs

-Center Card: new design.

Mircea Bogdan

# Beam Test Configuration—Readout



Readout Options:

- USB connection to Desktop
- Optical Link connection to Desktop with CERN designed O/L-PCI interface
- Optical Link connection to VME with existing Chicago MT2657 Card

(the MT2657 is a 6U VME Card with 2 x OL Transceivers TLK2501 and 1 Startix II FPGA)

Obs. NO NEW CUSTOM HARDWARE IS REQIRED FOR THE READOUT

Mircea Bogdan

## Beam Test DAQ System – Hardware Plans

- Install and test remaining PSEC3 QPF chips on current Analog and Digital Cards. We can do a preliminary Tray Operational Test with existing hardware and USB connection (2 or 4 Analog Cards, and only 2 pieces PSEC3 per Analog Card).
- Install and test PSEC3 dies on existing flip-chip mezzanine cards.
- Design and build Rev. B Mezzanine card for testing the new PSEC3A.
- Design and build Rev. B Analog Card to accommodate the new PSEC3A.
- Design and build Rev. B Digital Card to service 5 ASICs.
- Design and build new Center Card.

# Beam Test DAQ System - Schedule

